International Rectifier

- Ultra Low On-Resistance
- Surface Mount (IRFR4105)
- Straight Lead (IRFU4105)
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

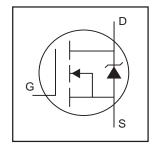
Description

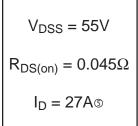
Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

The D-PAK is designed for surface mounting using vapor phase, infrared, or wave soldering techniques. The straight lead version (IRFU series) is for throughhole mounting applications. Power dissipation levels up to 1.5 watts are possible in typical surface mount applications.

PD - 95550A IRFR4105PbF IRFU4105PbF

HEXFET® Power MOSFET







Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V	27⑤	
$I_D @ T_C = 100^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V	19	A
I_{DM}	Pulsed Drain Current ①⑦	100	
P _D @T _C = 25°C	Power Dissipation	68	W
	Linear Derating Factor	0.45	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy@@	65	mJ
I _{AR}	Avalanche Current⊕⑦	16	A
E _{AR}	Repetitive Avalanche Energy ① ⑦	6.8	mJ
dv/dt	Peak Diode Recovery dv/dt ③	5.0	V/ns
T _J	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	

Thermal Resistance

	Parameter	Тур.	Max.	Units
R _{θJC}	Junction-to-Case		2.2	
$R_{\theta JA}$	Junction-to-Ambient (PCB mount) **		50	°C/W
Rom	Junction-to-Ambient		110	1

IRFR/U4105PbF

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.052		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.045		V _{GS} = 10V, I _D = 16A ⊕
V _{GS(th)}	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
g _{fs}	Forward Transconductance	6.5			S	V _{DS} = 25V, I _D = 16A⑦
I _{DSS}	Drain-to-Source Leakage Current			25	μA	$V_{DS} = 55V, V_{GS} = 0V$
				250		V _{DS} = 44V, V _{GS} = 0V, T _J = 150°C
1	Gate-to-Source Forward Leakage			100	^	V _{GS} = 20V
I _{GSS}	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20V
Qg	Total Gate Charge			34		I _D = 16A
Q _{gs}	Gate-to-Source Charge			6.8	nC	$V_{DS} = 44V$
Q _{gd}	Gate-to-Drain ("Miller") Charge			14		V _{GS} = 10V, See Fig. 6 and 13 ⊕ ⑦
t _{d(on)}	Turn-On Delay Time		7.0			$V_{DD} = 28V$
t _r	Rise Time		49		ns	$I_D = 16A$
$t_{d(off)}$	Turn-Off Delay Time		31		113	$R_G = 18\Omega$
t _f	Fall Time		40			$R_D = 1.8\Omega$, See Fig. 10 \oplus \oslash
L _D	Internal Drain Inductance		4.5		- nH	Between lead,
						6mm (0.25in.)
L _S	Internal Source Inductance		7.5			from package
						and center of die contact®
C _{iss}	Input Capacitance		700			$V_{GS} = 0V$
Coss	Output Capacitance		240		pF	$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		100			$f = 1.0$ MHz, See Fig. 5 \bigcirc

Source-Drain Ratings and Characteristics

	•													
	Parameter	Min.	Тур.	Max.	Units	Conditions								
Is	Continuous Source Current	27	07.6	27.6	MOSFET symbol									
	(Body Diode)		210	Α	showing the									
I _{SM}	Pulsed Source Current			100	400	400	400	400	400	400	400	400		integral reverse
	(Body Diode) ⊕ ⑦					p-n junction diode.								
V _{SD}	Diode Forward Voltage			1.6	V	T _J = 25°C, I _S = 16A, V _{GS} = 0V ④								
t _{rr}	Reverse Recovery Time		57	86	ns	$T_J = 25^{\circ}C, I_F = 16A$								
Q _{rr}	Reverse RecoveryCharge		130	200	nC	di/dt = 100A/µs ④⑦								
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)												

Notes:

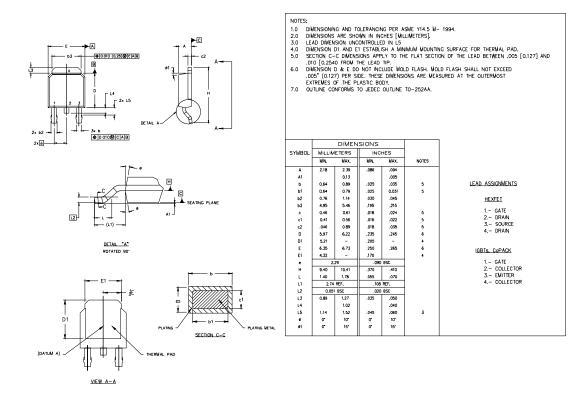
- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- $^{\odot}$ V_{DD} = 25V, starting T_J = 25°C, L = 410 μ H R_G = 25 Ω , I_{AS} = 16A. (See Figure 12)
- 4 Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$
- Calculated continuous current based on maximum allowable junction temperature; Package limitation current = 20A
- ® This is applied for I-PAK, Ls of D-PAK is measured between lead and center of die contact
- ① Uses IRFZ34N data and test conditions
- ** When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994

IRFR/U4105PbF

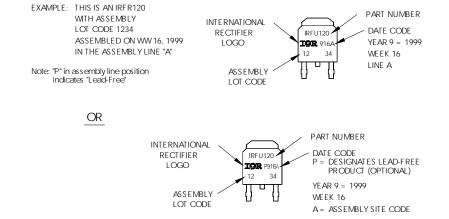


D-Pak (TO-252AA) Package Outline

Dimensions are shown in millimeters (inches)

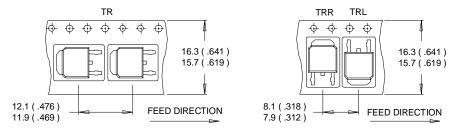


D-Pak (TO-252AA) Part Marking Information

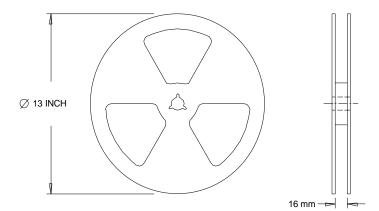


D-Pak (TO-252AA) Tape & Reel Information

Dimensions are shown in millimeters (inches)



- 1. CONTROLLING DIMENSION: MILLIMETER.
 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES:

1. OUTLINE CONFORMS TO EIA-481.

Data and specifications subject to change without notice.

International IOR Rectifier